## Application/Control No. 10/808,330 Applicant(s)/Patent Under Reexamination TOIZUMI ET AL. Examiner Huan H. Tran Applicant(s)/Patent Under Reexamination TOIZUMI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,565,963	10-1996	Tsujita et al.	399/48
	. В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	. 1	US-			
	J	US-			
	К	US-			
	L	US-		:	
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## NON-PATENT DOCUMENTS

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